

## Life Expectancy Report

Representative Test Model : S12038-8K

 $\bigcirc$  L<sub>10</sub>Expectancy: 70,000 hours minimum @ fan rated voltage and the temperature of 40°C According to the equation for Weibull distribution, MTTF  $\doteq$  7×L<sub>10</sub> = 490,000 hours And we rely on a zero failure Weibull test strategy and accelerated testing technique, to determine the total test time (t) for verifying the above life estimation by the equations,

 $t=1.036{\times}MTTF{\times}[(B_{r;c}){\div}~n]^{0.91}{\div}A_F$  , and  $~A_F=2^{(Ts-Tu)/10}$ 

where,  $(B_{r,c})$  is Poisson distribution factor with the failure number of r equal to 0 and the decimal confidence level of c equal to 0.90(90%).

Stress/Elevated Temperature Ts (℃)	Unstress Temperature Tu (℃)	Acceleration Factor A <sub>F</sub>	Quantity of Test Devices n (pcs)	Possion Distribution Factor B <sub>r;c</sub>	Required test time with zero failure t (hours)	Actual test time with zero failure t (hours)	Verified MTTF	Verified L <sub>10</sub> (hours)
75	40	11.31	40	2.303	3,340	3,672.0	538,685	76,955

Test Progress:
----------------

Date for Test Beginning				Current Test Status		
2024-1-8 12:00 AM	2024-6-9 12:00 AM	□ In process	In process (exceed requested)	✓ Termination	3672	2.0
INSPECTION CRITERIA : 1.Current (Icc) variation fro	Temperature for MTTF Estimation (℃)	Acceleration Factor A <sub>F</sub>	Estimated MTTF (hours)	Estimated L <sub>10</sub> (hours)		
2.Rotational Speed variation 3.Acoustic variation : +/- 3	30	22.63	1,077,370	153,910		
<ul> <li>4.Inspecting external if there is any defects in fan</li> <li>5.Using the lowest voltage to inspect if the fan still operates</li> </ul>			40	11.31	538,685	76,955
			50	5.66	269,343	38,478
			60	2.83	134,671	19,239
				1.41	67,336	9,619
				0.71	33,668	4,810
			90	0.35	16,834	2,405
			Herewith , we could assume as right on the basis of above test result. Besides, if the actual test time exceed the required, it comes out that those fans' L10 expectancy and MTTF are greater than the warrant.			

Time-out for function test or others (hours)			Review	Reported By
	2024-06-11			Hongye Lai